MPI T53500 300 mm Automated Probe Systems

The Dedicated Systems for Product Engineering with IceFreeEnvironment™

FEATURES / BENEFITS

Designed for Variety of On-Wafer Applications

- DC-IV / DC-CV / Pulsed-IV applications
- RF, mmW, load-pull applications & 4-port setup
- IC Design Validation, Failure Analysis in wide temperature range from -60 to 300 °C
- Wafer Level Reliability

WaferWallet® Option

- Designed with five individual trays for manual, ergonomic loading of 150, 200, or 300 mm "modeling" wafers
- Fully-automated tests with up to five identical wafers at multiple temperatures
- Unique capability to load/unload wafers at any temperature

Extended Flexibility

- MPI IceFreeEnvironment™ for using MicroPositioners and probe cards simultaneously, even at negative temperature
- Programmable microscope movements for more automation and ease of use
- The shortest cable interface to IC tester
- Minimize the platen-to-chuck distance for mmW & probing with active probes
- Supports film-frame probing

Ergonomic Design and Footprint

- Easy wafer or single DUT loading from the front
- Integrated active vibration isolation
- Completely integrated prober control for faster, safer and convenient system and test operation
- The Safety Test Management (STM™) with automated dew point control
- Reduced footprint due to smart chiller space arrangement
- Instrument shelf option for shorter cables and higher measurement dynamic



WAFERWALLET® SPECIFICATIONS



Wafer loading trays	5
Supported wafer sizes	150, 200, or 300 mm
Individual notch marks	0, 90, 180 & 270 deg for all wafer sizes
Hot and cold wafer swapping	Yes, local environmental chamber
Wafer pre-aligner	For 150, 200 and 300 mm, option
Wafer ID-Reader	Option for top or bottom ID reading Revolutionary integrated RGB illumination Fully automatic exposure control Code shift compensation OCR, Barcode, DataMatrix and QR code
Signal light tower	Four color, LED steady/flashing tower lights

STAGE SPECIFICATIONS

Chuck XY Stage (Programmable)

Travel range	310 mm x 310 mm (12.2 x 12.2 in)		
Resolution	0.5 μm		
Accuracy	± 2.0 μm (0.08 mils)		
XY stage drive	Closed-loop high precision stepper motors		
Speed	5-Speed XY chuck stage speed movement		
Max. movement speed	50 mm / sec		

Chuck Z Stage (Programmable)

Travel range	30 mm (1.18 in)
Resolution	0.2 μm
Accuracy	± 2 µm
Repeatability	± 1 µm
Z stage drive	Closed-loop high precision stepper motor
Guider	Precision ball bearings

STAGE SPECIFICATIONS

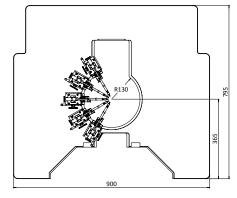
Chuck Theta Stage (Programmable)

Travel range	± 5.0°
Resolution	0.0001° (0.24 μm @ 300 mm edge)
Accuracy	< 2.0 µm (measured at the edge of the 300 mm chuck)
Repeatabilty	< 1.0 µm
Theta stage drive	High resolution stepper motor with linear encoder feedback system

PROBE PLATEN

Specifications

•			
Material	Nickel plated steel		
Chuck top to platen top	Min. 28 mm		
Platen cooling	Fully integrated CDA cooling, by using the chiller CDA		
Configuration	Probe card holder 4.5 x 11" and/or MicroPositioners		
Max. No. of MicroPositioners	10x DC MicroPositioners or 4x DC + 4x HF MicroPositioner Setup		
RF MicroPositioner mounting	Magnetic with guided rail		
DC MicroPositioner mounting	Magnetic		





Large Probe Platen supporting up to 10x DC or 4x DC + 4x RF MicroPositioners or standard 4.5" probe card holder

MICROSCOPE MOVEMENT

XYZ Programmable

XY - Travel range*		50 x 50 mm / 300 x 300 mm	
Resolution	1 μm (0.04 mils)		
Repeatability		≤ 2 µm (0.08 mils)	
Accuracy		≤ 5 µm (0.2 mils)	
Z - Travel range		140 mm	
Resolution		0.05 μm (0.002 mils)	
Repeatability		≤ 2 µm (0.08 mils)	
Accuracy		≤ 4 µm (0.16 mils)	
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PARK

IceFreeEnvironment™

MPI IceFreeEnvironment™ provides unique capability to perform measurements with probe cards and MicroPositioners simultaneously, especially at negative temperatures down to -60 °C.

Internal node probing with active/passive high impedance probes is very convenient.

The optimized design with minimal tip drop for highest dynamic range and gamma of mmWave and Load Pull measurements make the system an ideal choice for RF/mmW applications on 300 mm wafers.





WAFER LOADING

Loading or unloading of 150, 200 or 300 mm wafers or substrates is straight forward and intuitive. Special designed chucks allowing easy single ICs or wafer fragments loading in the front. Furthermore MPI SmartVacuum™ technology allows automated wafer size or single Die recognition and protects the wafer in case of power interruptions or inexperience operators from releasing the vacuum inside the IceFreeEnvironment™.

No roll-out stage allows for a simple method of automation for RF calibration and probe card cleaning. Easy access to the AUX chucks for handling of calibration substrates, cleaning or contact check pads.







^{*}In case of ShielDEnvironment™ X x Y: 25 mm x 25 mm

INTEGRATED CONTROLS

The thermal chuck can be operated by using the fully integrated touchscreen display, placed at convenient location in front of the operator for fast operation and immediate feedback.

The intelligent hardware control panel is completely integrated into the probe system and is designed to provide faster, safer and convenient system control and test operation.

The Keyboard and mouse are strategically located to control the software and it can also control the Windows® based instrumentation.

USB connection to the systems controller is located right in front for convenient data exchange.







■ Probe Hover Control™

MPI Probe Hover Control PHC™ allows easy manual control of probe contact and separation to wafer. Separation distance can accurately control with micrometer feedback for probe to wafer/pad positioning. Ease of use guarantees the safest operation by minimizing error during critical setup and probe change operations.

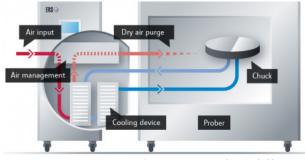


THERMAL CHILLER INTEGRATION

Minimized CDA Consumption

With the ERS patented technology, using the chiller for purging the IceFreeEnvironment[™], the CDA consumption is reduced by as much as 50%. Nitrogen purging is also possible by using separate, automated valve.

This "refurbished" CDA is used in addition for probe platen and probe card cooling.



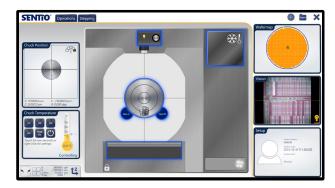
* Picture is courteously provided by ERS.

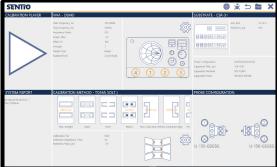
SOFTWARE SOLUTION

MPI automated engineering probe systems are controlled by a unique and revolutionary, multi-touch operation SENTIO® Software Suite – simple and intuitive operation saves significant training time, the Scroll, Zoom, and Move commands mimic modern smart mobile devices and allows everyone to become an expert in just minutes. Switching between the active application and the rest of the APPs is just a matter of a simple finger sweep.

By implementing intuitive multi-touch operation, QAlibria® provides crisp and clear guidance to the RF calibration process, minimizes configuration mistakes and helps to reach accurate calibration results in fastest time. QAlibria® offers industry standard and advanced calibration methods.

QAlibria® includes TOSM (SOLT), TMR, TMRR methods, and 4-port calibration capability additionally to the integration of NIST StatistiCal calibration packages providing easy access to the NIST multiline TRL metrology-level calibration and uncertain analysis.





NON-THERMAL CHUCKS

Wafer Chuck	Standard	Triaxial	
Connectivity	Coax BNC (f)	Kelvin Triax (f)	
Diameter	310 mm with 2 integrated AUX areas		
Material	Nickel plated aluminum (flat with 0.5 mm holes)		
Chuck surface	Planar with 0.5 mm diameter holes in centric sections		
Vacuum holes sections (diameter)	4, 24, 48, 72, 96, 120, 144, 168, 192, 216, 240, 264, 288 mm		
SmartVacuum™ distribution	In front for single DUT 4x4 mm (4 holes) and 75 mm (3 in) In center for 150, 200, 300 mm (6, 8, 12 in)		
Surface planarity	≤± 5 µm**		
Rigidity	< 15 µm / 10 N @edge		
Rigidity	15 µm/ 10 W @cage		

 $[\]hbox{``Single DUT testing requires higher vacuum conditions dependent upon testing application.}$

Triaxial RF Wafer Chuck

Connectivity	Kelvin Triax (f)		
Diameter	310 mm with 2 integrated AUX chucks		
Material	Nickel plated aluminum (flat with 0.5 mm holes)		
Chuck surface	Planar with 0.5 mm diameter holes in centric sections		
Vacuum holes sections (diameter)	4, 24, 48, 72, 96, 120, 144, 168, 192, 216, 240, 264, 288 mm		
SmartVacuum™ distribution	In front for single DUT 4x4 mm (4 holes) and 75 mm (3 in) In center for 150, 200, 300 mm (6, 8, 12 in)		
Surface planarity	≤± 5 μm**		
Rigidity	< 15 µm / 10 N @edge		

^{*}Single DUT testing requires higher vacuum conditions dependent upon testing application.

Auxiliary Chuck

Quantity	2 AUX chucks
Position	Integrated to front side of main chuck
Substrate size (W x L)	Max. 25 x 25 mm (1 x 1 in)
Material	Ceramic, RF absorbing material for accurate calibration
Surface planarity	≤± 5 µm
Vacuum control	Controlled independently, separate from chucks

Electrical Specification (Coax)

Operation voltage	In accordance with EC 61010, certificates for higher voltages available upon request
Maximum voltage between chuck top and GND	500 V DC
Isolation	> 2 GΩ

Electrical Specification (Triax)

Chuck Isolation	At 10 V
Force-to-Guard	> 5 T Ohm
Guard-to-Shield	> 1 T Ohm
Force-to-Shield	> 5 T Ohm

^{**}By using SENTIO® topography

^{**}By using SENTIO® topography

THERMAL CHUCKS

Specifications of MPI ERS AirCool® PRIME Technology

	Ambient to 200/300 °C	20 °C to 200/300 °C	Ambient to 200/300 °C	20 °C to 200/300 °C
Chuck type	RF	RF	Ultra low noise	Ultra low noise
Connectivity	Kelvin Triax (f)	Kelvin Triax (f)	Kelvin Triax (f)	Kelvin Triax (f)
Temperature control method	Cooling air / Resistance heater	Cooling air / Resistance heater	Cooling air / Resistance heater	Cooling air / Resistance heater
Coolant	Air (user supplied)	Air (user supplied)	Air (user supplied)	Air (user supplied)
Smallest temperature selection step	0.1 °C	0.1 °C	0.1 °C	0.1 °C
Chuck temperature display resolution	0.01 °C	0.01 °C	0.01 °C	0.01 °C
External touchscreen display operation	Yes	Yes	Yes	Yes
Temperature stability	±0.5 °C	±0.05 °C	±0.05 °C	±0.05 °C
Temperature accuracy	±0.1 °C	0.1 °C	0.1 °C	0.1 °C
Control method	Low noise DC/PID	Low noise DC/PID	Low noise DC/PID	Low noise DC/PID
Chuck pinhole surface plating: 200°C / 300°C	Nickel / Gold	Nickel / Gold	Nickel / Gold	Nickel / Gold
SmartVacuum™ distribution	In fro		nm (4 holes) and 75 mm 0, 300 mm (6, 8, 12 in)	n (3 in)
Temperature sensor	Pt100 1/3DIN, 4-line wired	Pt100 1/3DIN, 4-line wired	Pt100 1/3DIN, 4-line wired	Pt100 1/3DIN, 4-line wired
Temperature uniformity	<±0.5 °C at ≤ 200 °C <±1 °C at > 200 °C	< ±0.5 °C at ≤ 200 °C < ±1 °C at > 200 °C	<±0.5 °C at ≤ 200 °C <±1 °C at > 200 °C	< ±0.5 °C at ≤ 200 °C < ±1.0 °C at > 200 °C
Surface flatness and base parallelism	<±12 µm	<±12 μm	<±12 µm	<±12 µm
Max. Voltage between				
Force-to-GND	600 V DC	600 V DC	600 V DC	600 V DC
Force-to-Guard	100 V DC	100 V DC	600 V DC	600 V DC
Heating rates		20 to 200 °C < 18 min 20 to 300 °C < 28 min		20 to 200 °C < 20 min 20 to 300 °C < 30 min
Cooling rates*		200 to 20 °C < 30 min 300 to 20 °C < 38 min	200 to 35 °C < 30 min 300 to 35 °C < 38 min	200 to 20 °C < 33 min 300 to 20 °C < 40 min
Leakage @ 10 V	N/A	N/A	< 15 fA at 25 °C < 30 fA at 200 °C < 50 fA at 300 °C	< 15 fA at 25 °C < 30 fA at 200 °C < 50 fA at 300 °C
Electrical isolation	> 5 T Ω at 25 °C > 1 T Ω at 200 °C > 0.5 T Ω at 300 °C	> 5 T Ω at 25 °C > 1 T Ω at 200 °C > 0.5 T Ω at 300 °C	N/A	N/A
Capacitance				
Force-to-Guard	< 1600 pF	< 1600 pF	< 600 pF	< 600 pF
Guard-to-Shield	< 2000 pF	< 2000 pF	< 2000 pF	< 2000 pF

^{*}All data are relevant for chucks in ECO mode.

Specifications of MPI ERS AirCool® PRIME Technology

	-10 °C to 200/300 °C	-40 °C to 200/300 °C Ultra low noise	-60 °C to 200/300 °C		
Chuck type	Ultra low noise	Ultra low noise			
Connectivity	Kelvin Triax (f)	.,			
Temperature control method			Cooling air / Resistance heater		
Coolant	Air (user supplied)	Air (user supplied)	Air (user supplied)		
Smallest temperature selection step	0.1 °C	0.1 °C	0.1 °C		
Chuck temperature display resolution	0.01 °C	0.01 °C	0.01 °C		
External touchscreen display operation	Yes	Yes	Yes		
Temperature stability	±0.08 °C	±0.08 °C	±0.08 °C		
Temperature accuracy	0.1 °C	0.1 °C	0.1 °C		
Control method	Low noise DC/PID	Low noise DC/PID	Low noise DC/PID		
Interfaces	RS232C	RS232C	RS232C		
Chuck pinhole surface plating: 200°C / 300°C	Nickel / Gold	Nickel / Gold	Nickel / Gold		
SmartVacuum™ distribution	-	gle DUT 4x4 mm (4 holes) ar er for 150, 200, 300 mm (6, 8			
Temperature sensor	Pt100 1/3DIN, Pt100 1/3DIN, 4-line wired 4-line wired		Pt100 1/3DIN, 4-line wired		
Temperature uniformity	<pre><±0.5 °C at ≤ 200 °C</pre>		<±0.5 °C at ≤ 200 °C <±1.0 °C at > 200 °C		
Surface flatness and base parallelism	<±12 μm	<±12 μm	<±12 µm		
Max. Voltage between					
Force-to-GND	600 V DC	600 V DC	600 V DC		
Force-to-Guard	600 V DC	600 V DC	600 V DC		
Heating rates					
25℃	-10 to 25 °C < 10 min	-40 to 25 °C < 12 min	-60 to 25 °C < 15 min		
200 ℃		25 to 200 °C < 20 min			
300 °C		25 to 300 °C < 35 min			
Cooling rates*					
300 °C	300 to 25 °C < 38 min	300 to 25 °	°C < 35 min		
200 °C	200 to 25 °C < 30 min		C < 25 min		
25 °C	25 to -10 °C < 30 min	25 to -40 °C < 65 min	25 to -60 °C < 45 min		
Leakage @ 10 V					
-10, -40 or -60 °C	< 30 fA	< 30 fA	< 30 fA		
25 °C	< 15 fA	< 15 fA	< 15 fA		
200 °C	< 30 fA < 30 fA		< 30 fA		
300 °C	< 50 fA	< 50 fA	< 50 fA		
Capacitance Force-to-Guard	< 600 pF	< 600 pF	< 600 pF		
Guard-to-Shield	< 2000 pF	< 2000 pF	< 2000 pF		
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^{*}All data are relevant for chucks in ECO mode.

Specifications of MPI ERS AirCool® PRIME Technology

	-10 °C to 200/300 °C	-40 °C to 200/300 °C	-60 °C to 200/300 °C	
Chuck type	RF	RF	RF	
Connectivity	Kelvin Triax (f)	Kelvin Triax (f)	Kelvin Triax (f)	
Temperature control method	Cooling air / Resistance heater	Cooling air / Resistance heater	Cooling air / Resistance heater	
Coolant	Air (user supplied)	Air (user supplied)	Air (user supplied)	
Smallest temperature selection step	0.1 °C	0.1 °C	0.1 °C	
Chuck temperature display resolution	0.01 °C	0.01 °C	0.01 °C	
External touchscreen display operation	Yes	Yes	Yes	
Temperature stability	±0.08 °C	±0.08 °C	±0.08 °C	
Temperature accuracy	0.1 °C	0.1 °C	0.1 °C	
Control method	Low noise DC/PID	Low noise DC/PID	Low noiseDC/PID	
Interfaces	RS232C	RS232C	RS232C	
Chuck pinhole surface plating: 200°C / 300°C	Nickel / Gold	Nickel / Gold	Nickel / Gold	
SmartVacuum™ distribution	In front for single DUT 4x4 mm (4 holes) and 75 mm (3 in) In center for 150, 200, 300 mm (6, 8, 12 in)			
Temperature sensor	Pt100 1/3DIN, 4-line wired	Pt100 1/3DIN, 4-line wired	Pt100 1/3DIN, 4-line wired	
Temperature uniformity	<±0.5 °C at ≤ 200 °C <±1 °C at > 200 °C	<±0.5 °C at ≤ 200 °C <±1 °C at > 200 °C	<±0.5 °C at ≤ 200 °C <±1.0 °C at > 200 °C	
Surface flatness and base parallelism	<±12 μm	< ±12 µm	< ±12 µm	
Max. Voltage between				
Force-to-GND	600 V DC	600 V DC	600 V DC	
Force-to-Guard	100 V DC	100 V DC	100 V DC	
Heating rates				
25℃	-10 to 25 °C < 8 min	-40 to 25 °C < 10 min	-60 to 25 °C < 12 min	
200 °C		25 to 200 °C < 18 min		
300 °C		25 to 300 °C < 30 min		
Cooling rates*				
300 °C	300 to 25 °C < 35 min	300 to 25 °	C < 32 min	
200 °C	200 to 25 °C < 28 min 200 to 25 °C < 22 min			
25℃	25 to -10 °C < 28 min		25 to -60 °C < 40 min	
Leakage @ 10 V	N/A	N/A	N/A	
Electrical isolation	.,,.	> 5 T Ω at 25 °C or below > 1 T Ω at 200 °C > 0.5 T Ω at 300 °C	,.	
Capacitance				
Force-to-Guard	< 1600 pF	< 1600 pF	< 1600 pF	
Guard-to-Shield	< 2000 pF	< 2000 pF	< 2000 pF	

^{*}All data are relevant for chucks in ECO mode.

High Temperature Uniformity Option*

HTU Option -60 °C		°C	-50 ℃		-35 ℃		0°C	
	typical	max	typical	max	typical	max	typical	max
Accuracy	±0.015	±0.05	±0.015	±0.05	±0.015	±0.05	±0.02	±0.05
Uniformity	±0.4	±0.5	±0.4	±0.5	±0.3	±0.5	±0.15	±0.2
HTU Option		35 ℃		50)°C		70 °C	
	typical	max	(typical	max	typ	ical	max
Accuracy	±0.02	±0.05	5	±0.02	±0.05	±0.	025	±0.05
Uniformity	±0.08	±0.1		±0.08	±0.1	±0	.09	±0.01

^{*} Only for RF thermal chucks.

THERMAL CHUCKS DIMENSIONS

System Controller / Chiller Dimensions and Power / Air Consumption

System type	W x D x H (mm)	Weight (kg)	Power cons. (VA)	max. Air flow* (l/min)	CDA dew Point
Ambient	300 x 360 x 135	12	1200	400	≤ 0 °C
20 °C, -10 °C to 200 / 300 °C	300 x 360 x 135	12	1200	400	≤ -30 °C
-40 to 200 / 300 °C	420 x 300 x 520	45	1200	400	≤ -40 °C
-60 to 200 / 300 °C	420 x 500 x 1020	140	2400	450	≤ -40 °C
Electrical primary connection		10	0 to 240 VAC au	ıto switch	
Electrical frequency			50 Hz / 60	Hz	
Compressed air supply		(6.0 bar (0.8 MPa	ı, 87 psi)	



ERS AirCool® (patented) Controller Integrated Chiller -60 °C

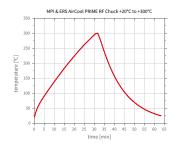


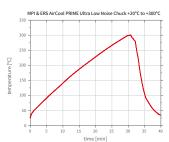
ERS AirCool® (patented) Controller Integrated Chiller -40 °C

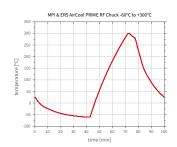


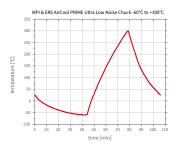
ERS and MPI's joint product AirCool® PRIME Chuck won "Electronics Industry Awards 2018" in the category, "Test, Measurement and Inspection Product of the year".

TYPICAL TRANSITION TIME









SYSTEM CONTROLLER SPECIFICATIONS

CPU	Intel® Core™ i7-7700,3.6 GHz, 8M Cache, 14nm, 65W TDP, LGA1151(4C/8T)
RAM	DDR4 2400 MHz 16 GB x 1
64 bit operating system	Windows 10 Professional (English)
Power	460 W
Storage	SSD 500 GB
LAN	One internal and one external TCP/IP ports
USB Ports	Internal (on PC) x3, external x1
GPIB interface	Optional

SUPPORTED SOFTWARE PLATFORMS

Drivers	WaferPro / IC-CAP & EasyEXPERT from Keysight, BSIMPro & NoisePro from ProPlus, ACS from Keithley
Emulation mode	Available for various prober control software*

^{*} Please contact your local support for more details.

FACILITY REQUIREMENTS

General Probe System

Power	100-240 V AC nominal ; 50/60 Hz
Vacuum	-0.9 bar
Compressed air	6.0 bar

REGULATORY COMPLIANCE

3rd party, TÜV tested according to

• IEC 61010-1: 2010 + Am1:2016; EN 61010-1: 2010; IEC/EN 61010-2-010: 2014; IEC/EN 61010-2-081: 2015; EN ISO 12100: 2010; UL 61010-1: 2012/R: 2016-04; UL 61010-2-010: 2015; CAN/CSA-C22.2 No. 61010-1: 2012/U2: 2016-04; CAN/CSA-C22.2 No. 61010-2-010:2015

and certified for CE and US/Canada (NRTL), SEMI S2 and S8.

Copies of certificates are available on request

WARRANTY

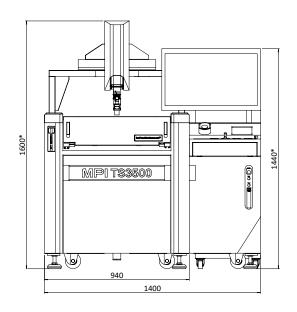
- Warranty*: 12 months
- Extended service contract: contact MPI Corporation for more information

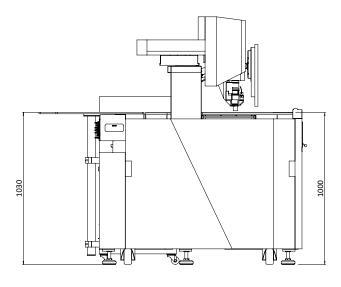
PHYSICAL DIMENSIONS

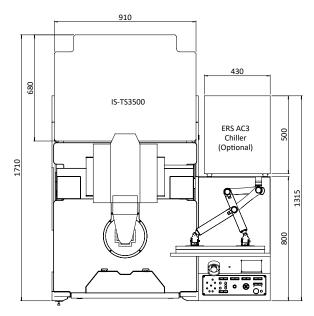
TS3500

System dimensions (W x D x H)	1400 x 1315 x 1600 mm (55.1 x 51.8 x 63.0 in)
Weight	850 kg

^{*}Can vary depends on monitor/chiller position.







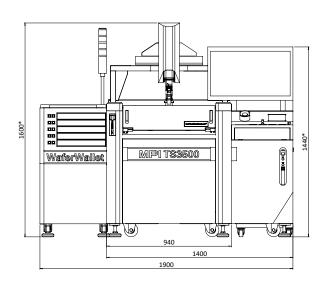
^{*}See MPI Corporation's Terms and Conditions of Sale for more details.

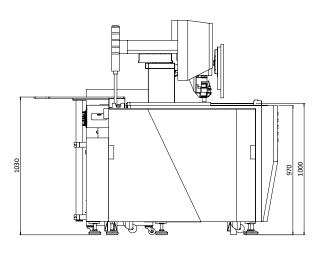
WaferWallet°

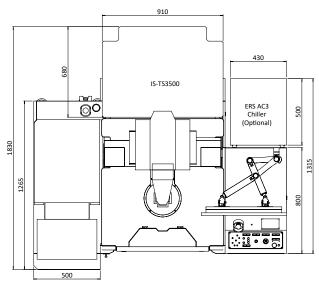
System dimensions (W x D x H)	500 x 1265 x 970 mm (19.7 x 49.8 x 38.2 in)
Weight	200 kg

^{*}Can vary depends on monitor/chiller position.

TS3500 with WaferWallet®







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America region: ast-americas@mpi-corporation.com

MPI global presence: for your local support, please find the right contact here: www.mpi-corporation.com/ast/support/local-support-worldwide

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